

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567375	YABE, TAKAYUKI
Examiner	Art Unit	
David M Fenstermacher	3656	

SEARCHED

Class	Subclass	Date	Examiner
74	89.23		
	89.36		
	89.44		
	89.45		
	424.71		
	424.7	11/4/08	/DMF/

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

	/David M Fenstermacher/ Primary Examiner, Art Unit 3656
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